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S/N 10/532953

612,455,3801

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

NAKANO, et al.

Examiner:

FRITCHMAN, Rebecca M

Serial No.:

10/532953

Group Art Unit:

1797

Filed:

April 27, 2005

Docket No.:

10921.0314USWO

Title:

METHOD OF CORRECTION AT SAMPLE ANALYSIS, ANALYZER

AND ANALYTICAL EQUIPMENT

CERTIFICATE UNDER 37 CFR 1.6(d):

1 hereby certify that this paper is being transmitted by facsimile to the U.S. Patent and Trademark Office on August 19.

AMENDMENT AND RESPONSE

Mail Stop: AMENDMENT Commissioner for Patents

P.O. Box 1450

Alexandria, Virginia 22313-1450

Dear Commissioner:

In response to the Office Action mailed February 20, 2009, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims that begins on page 2 of this paper.

Remarks begin on page 7 of this paper.